3.3 V Zero Delay Clock Buffer

The NB2309A is a versatile, 3.3 V zero delay buffer designed to distribute high–speed clocks. It accepts one reference input and drives out nine low–skew clocks. It is available in a 16 pin package.

The -1H version of the NB2309A operates at up to 133 MHz, and has higher drive than the -1 devices. All parts have on-chip PLL's that lock to an input clock on the REF pin. The PLL feedback is on-chip and is obtained from the CLKOUT pad.

The NB2309A has two banks of four outputs each, which can be controlled by the Select inputs as shown in the Select Input Decoding Table. If all the output clocks are not required, Bank B can be three-stated. The select inputs also allow the input clock to be directly applied to the outputs for chip and system testing purposes.

Multiple NB2309A devices can accept the same input clock and distribute it. In this case the skew between the outputs of the two devices is guaranteed to be less than 700 ps.

All outputs have less than 200 ps of cycle–to–cycle jitter. The input and output propagation delay is guaranteed to be less than 350 ps, and the output to output skew is guaranteed to be less than 250 ps.

The NB2309A is available in two different configurations, as shown in the ordering information table. The NB2309A1 is the base part. The NB2309Ax1H* is the high drive version of the -1 and its rise and fall times are much faster than -1 part.

Features

- 15 MHz to 133 MHz Operating Range, Compatible with CPU and PCI Bus Frequencies
- Zero Input Output Propagation Delay
- Multiple Low-Skew Outputs
- Output-Output Skew Less than 250 ps
- Device-Device Skew Less than 700 ps
- One Input Drives 9 Outputs, Grouped as 4 + 4 + 1
- Less than 200 ps Cycle-to-Cycle Jitter is Compatible with Pentium® Based Systems
- Test Mode to Bypass PLL
- Available in 16 Pin, 150 mil SOIC and 4.4 mm TSSOP
- 3.3 V Operation, Advanced 0.35 µ CMOS Technology
- These are Pb-Free Devices**



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MARKING **DIAGRAMS*** ¹⁶ A A A A A A A A A XXXXXXXXG AWLYWW SOIC-16 Η **D SUFFIX** CASE 751B 1688888888 XXXX XXXX ALYW-TSSOP-16 НННН DT SUFFIX CASE 948F XXXX = Device Code = Assembly Location Δ WL, L = Wafer Lot Y = Year W, WW = Work Week

G or • = Pb-Free Package

*For additional marking information, refer to Application Note AND8002/D.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 7 of this data sheet.

**For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

^{*}x = C for Commercial; I for Industrial.

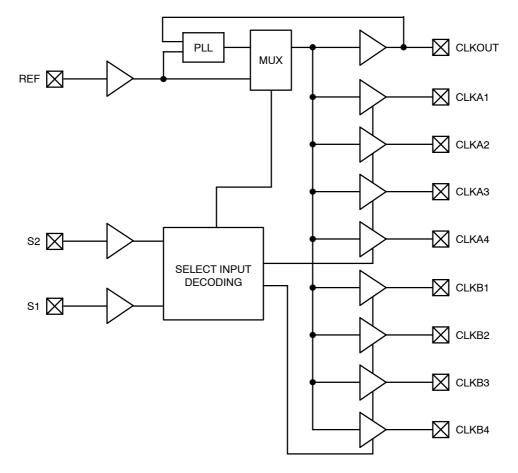
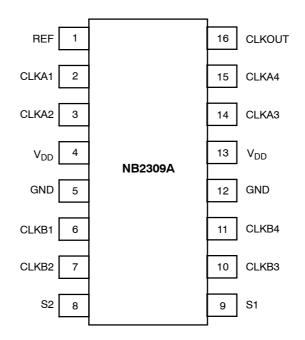


Figure 1. Block Diagram

S2	S1	Clock A1 – A4	Clock B1 – B4	CLKOUT (Note 1)	Output Source	PLL ShutDown
0	0	Three-state	Three-state	Driven	PLL	Ν
0	1	Driven	Three-state	Driven	PLL	Ν
1	0	Driven	Driven	Driven	Reference	Y
1	1	Driven	Driven	Driven	PLL	Ν

Table 1. SELECT INPUT DECODING

1. This output is driven and has an internal feedback for the PLL. The load on this output can be adjusted to change the skew between the reference and the output.



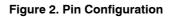


Table 2. PIN DESCRIPTION

Pin #	Pin Name	Description
1	REF (Note 2)	Input reference frequency, 5 V tolerant input.
2	CLKA1 (Note 3)	Buffered clock output, Bank A.
3	CLKA2 (Note 3)	Buffered clock output, Bank A.
4	V _{DD}	3.3 V supply.
5	GND	Ground.
6	CLKB1 (Note 3)	Buffered clock output, Bank B.
7	CLKB2 (Note 3)	Buffered clock output, Bank B.
8	S2 (Note 4)	Select input, bit 2.
9	S1 (Note 4)	Select input, bit 1.
10	CLKB3 (Note 3)	Buffered clock output, Bank B.
11	CLKB4 (Note 3)	Buffered clock output, Bank B.
12	GND	Ground.
13	V _{DD}	3.3 V supply.
14	CLKA3 (Note 3)	Buffered clock output, Bank A.
15	CLKA4 (Note 3)	Buffered clock output, Bank A.
16	CLKOUT (Note 3)	Buffered output, internal feedback on this pin.

Weak pulldown.
 Weak pulldown on all outputs.
 Weak pullup on these inputs.

Table 3. MAXIMUM RATINGS

Parameter	Min	Max	Unit
Supply Voltage to Ground Potential	-0.5	+7.0	V
DC Input Voltage (Except REF)	-0.5	V _{DD} + 0.5	V
DC Input Voltage (REF)	-0.5	7	V
Storage Temperature	-65	+150	°C
Maximum Soldering Temperature (10 sec)		260	°C
Junction Temperature		150	°C
Static Discharge Voltage (per MIL-STD-883, Method 3015)		>2000	V

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

Table 4. OPERATING CONDITIONS FOR COMMERCIAL AND INDUSTRIAL TEMPERATURE DEVICES

Parameter	Description	Min	Max	Unit	
V _{DD}	Supply Voltage		3.0	3.6	V
T _A	Operating Temperature (Ambient Temperature)	Commercial	0	70	°C
		Industrial	-40	85	
CL	Load Capacitance, below 100 MHz			30	pF
CL	Load Capacitance, from 100 MHz to 133 MHz			10	pF
C _{IN}	Input Capacitance			7	pF

Table 5. ELECTRICAL CHARACTERISTICS FOR COMMERCIAL AND INDUSTRIAL TEMPERATURE DEVICES

Parameter	Description	Test Conditions	Min	Max	Unit
V _{IL}	Input LOW Voltage (Note 5)			0.8	V
V _{IH}	Input HIGH Voltage (Note 5)		2.0		V
I _{IL}	Input LOW Current	V _{IN} = 0 V		50.0	μΑ
I _{IH}	Input HIGH Current	V _{IN} = V _{DD}		100.0	μΑ
V _{OL}	Output LOW Voltage	I _{OL} = 8 mA (-1) I _{OL} = 12 mA (-1H)		0.4	V
V _{OH}	Output HIGH Voltage	I _{OH} = -8 mA (-1) I _{OH} = -12 mA (-1H)	2.4		V
I _{DD}	Supply Current (Commercial Temp)	Unloaded outputs at 66.67 MHz, Select inputs at V_{DD}		34	mA
I _{DD}	Supply Current (Industrial Temp)	Unloaded outputs at 100 MHz 66.67 MHz 33 MHz Select inputs at V _{DD} or GND, at Room Temp		50 34 19	mA

5. REF input has a threshold voltage of $V_{DD}/2$.

Parameter	Description	Test Conditions	Min	Тур	Max	Unit
1/t ₁	Output Frequency	30 pF load 10 pF load	15 15		100 133.33	MHz
1/t ₁	Duty Cycle = $(t_2 / t_1) * 100$ (-1, -1H) (-1H)	Measured at 1.4 V, F _{OUT} = 66.67 MHz < 50 MHz	40 45	50 50	60 55	%
t ₃	Output Rise Time (-1, -1H) (-1H)	Measured between 0.8 V and 2.0 V			2.5 1.5	ns
t ₄	Output Fall Time	Measured between 2.0 V and 0.8 V			1.5	ns
t ₅	Output-to-Output Skew	All outputs equally loaded			250	ps
t ₆	Delay, REF Rising Edge to CLKOUT Rising Edge	Measured at V _{DD} /2		0	±350	ps
t ₇	Device-to-Device Skew	Measured at $V_{\mbox{DD}}/2$ on the CLKOUT pins of the device		0	700	ps
t ₈	Output Slew Rate	Measured between 0.8 V and 2.0 V using Test Circuit #2	1			V/ns
tj	Cycle-to-Cycle Jitter	Measured at 66.67 MHz, loaded outputs			200	ps
t _{LOCK}	PLL Lock Time	Stable power supply, valid clock presented on REF pin			1.0	ms
tr _{in}	REF Input Rise Time	Measured between 0.8 V to 2.0 V			1.0	ns
tf _{in}	REF Input Rise Fall Time	Measured between 2.0 V to 0.8 V			1.0	ns

Table 6. SWITCHING CHARACTERISTICS (Commercial and Industrial) (Note 6)

6. All parameters specified with loaded outputs and apply to both PLL-Mode and PLL-Bypass Mode.

Zero Delay and Skew Control

All outputs should be uniformly loaded to achieve Zero Delay between input and output. Since the CLKOUT pin is the internal feedback to the PLL, its relative loading can adjust the input–output delay. For applications requiring zero input–output delay, all outputs, including CLKOUT, must be equally loaded. Even if CLKOUT is not used, it must have a capacitive load equal to that on other outputs, for obtaining zero–input–output delay.

SWITCHING WAVEFORMS

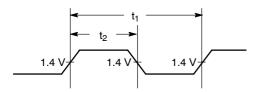


Figure 3. Duty Cycle Timing

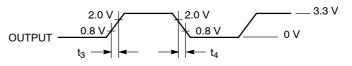


Figure 4. All Outputs Rise/Fall Time

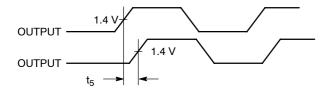


Figure 5. Output – Output Skew

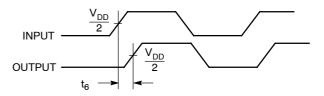


Figure 6. Input – Output Propagation Delay

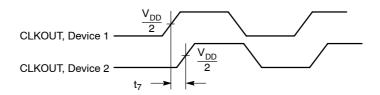
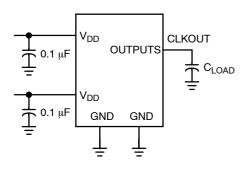


Figure 7. Device – Device Skew

TEST CIRCUITS



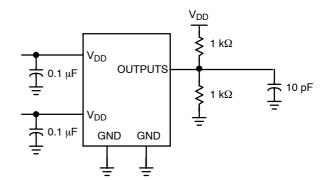


Figure 8. Test Circuit #1

Figure 9. Test Circuit #2 For parameter t₈ (output slew rate) on –1H devices

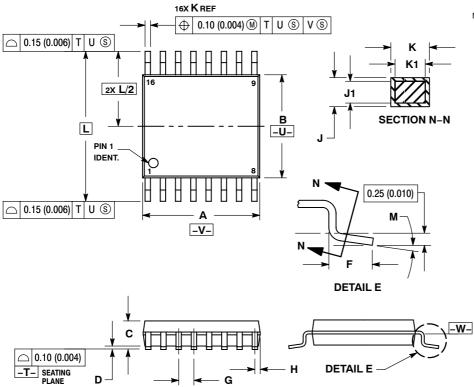
ORDERING INFORMATION

Device	Marking	Operating Range	Package	Shipping [†]	Availability
NB2309AC1DG	2309AC1G	Commercial	SOIC-16 (Pb-Free)	48 Units / Rail	Now
NB2309AC1DR2G	2309AC1G	Commercial	SOIC-16 (Pb-Free)	2500 Tape & Reel	Now
NB2309AI1DG	2309AI1G	Industrial	SOIC-16 (Pb-Free)	48 Units / Rail	Now
NB2309AI1DR2G	2309Al1G	Industrial	SOIC-16 (Pb-Free)	2500 Tape & Reel	Now
NB2309AC1HDG	2309AC1HG	Commercial	SOIC-16 (Pb-Free)	48 Units / Rail	Now
NB2309AC1HDR2G	2309AC1HG	Commercial	SOIC-16 (Pb-Free)	2500 Tape & Reel	Now
NB2309AI1HDG	2309AI1HG	Industrial	SOIC-16 (Pb-Free)	48 Units / Rail	Now
NB2309AI1HDR2G	2309AI1HG	Industrial	SOIC-16 (Pb-Free)	2500 Tape & Reel	Now
NB2309AC1DTG	2309AC1	Commercial	TSSOP-16 (Pb-Free)	96 Units / Rail	Now
NB2309AC1DTR2G	2309AC1	Commercial	TSSOP-16 (Pb-Free)	2500 Tape & Reel	Now
NB2309AI1DTG	2309AI1	Industrial	TSSOP-16 (Pb-Free)	96 Units / Rail	Now
NB2309AI1DTR2G	2309Al1	Industrial	TSSOP-16 (Pb-Free)	2500 Tape & Reel	Now
NB2309AC1HDTG	2309AC1H	Commercial	TSSOP-16 (Pb-Free)	96 Units / Rail	Now
NB2309AC1HDTR2G	2309AC1H	Commercial	TSSOP-16 (Pb-Free)	2500 Tape & Reel	Now
NB2309AI1HDTG	2309AI1H	Industrial	TSSOP-16 (Pb-Free)	96 Units / Rail	Now
NB2309AI1HDTR2G	2309AI1H	Industrial	TSSOP-16 (Pb-Free)	2500 Tape & Reel	Now

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

TSSOP-16 CASE 948F-01 ISSUE A



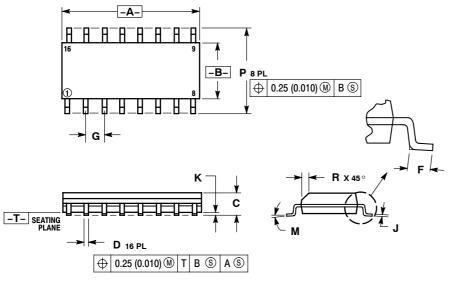
NOTES:

- NOTES:
 DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.06) PER SIDE.
 DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
 DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN
- PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION. 6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY. 7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.10	0.193	0.200
В	4.30	4.50	0.169	0.177
C		1.20		0.047
D	0.05	0.15	0.002	0.006
F	0.50	0.75	0.020	0.030
G	0.65	0.65 BSC		BSC
Н	0.18	0.28	0.007	0.011
J	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
K	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
L	6.40	6.40 BSC		BSC
М	0 °	8°	0° 8	

PACKAGE DIMENSIONS

SOIC-16 CASE 751B-05 ISSUE J



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
 DIMENSIONS A AND B DO NOT INCLUDE
- MOLD PROTRUSION. 4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- PER SIDE. 5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS		INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	9.80	10.00	0.386	0.393	
В	3.80	4.00	0.150	0.157	
C	1.35	1.75	0.054	0.068	
D	0.35	0.49	0.014	0.019	
F	0.40	1.25	0.016	0.049	
G	1.27	BSC	0.050	50 BSC	
J	0.19	0.25	0.008	0.009	
K	0.10	0.25	0.004	0.009	
Μ	0 °	7°	0 °	7°	
Ρ	5.80	6.20	0.229	0.244	
R	0.25	0.50	0.010	0.019	

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